

**N- AND P-CHANNEL ENHANCEMENT MODE POWER MOSFET**

# MTC4505Q8

	N-CH	P-CH
$BV_{DSS}$	30V	-30V
$I_D$	10A	-8.4A
$R_{DSON(max)}$	14m $\Omega$	20m $\Omega$

**Description**

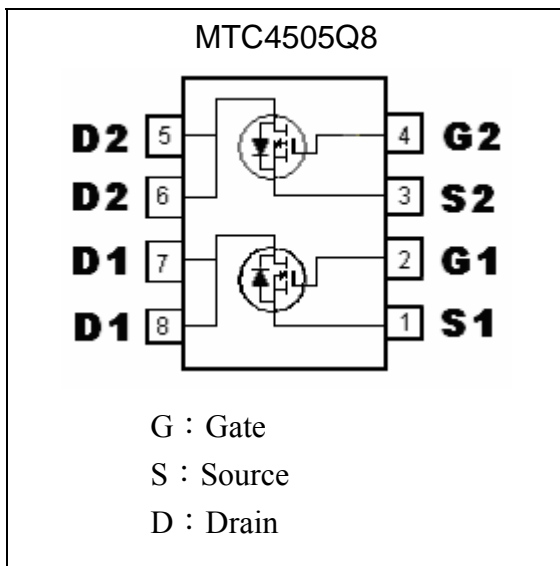
The MTC4505Q8 consists of a N-channel and a P-channel enhancement-mode MOSFET in a single SOP-8 package, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOP-8 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.

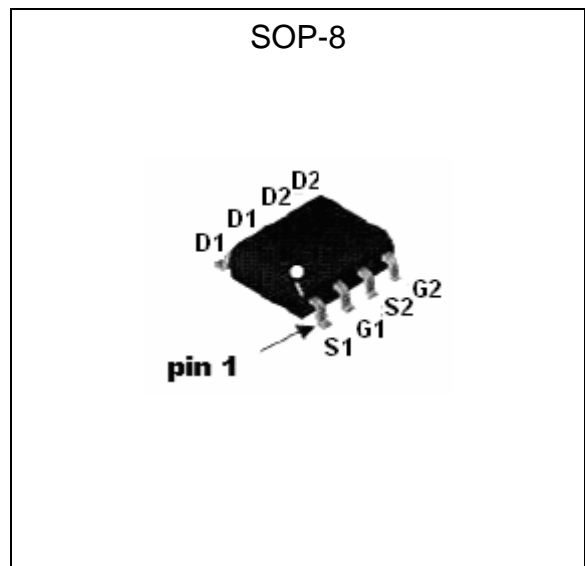
**Features**

- Simple drive requirement
- Low on-resistance
- Fast switching speed
- RoHS compliant package

**Equivalent Circuit**



**Outline**





**Absolute Maximum Ratings** (Tc=25°C, unless otherwise noted)

Parameter	Symbol	Limits		Unit
		N-channel	P-channel	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	30	-30	V
Gate-Source Voltage	V <sub>GS</sub>	±20	±20	V
Continuous Drain Current @T <sub>A</sub> =25 °C (Note 1)	I <sub>D</sub>	10	-8.4	A
Continuous Drain Current @T <sub>A</sub> =70 °C (Note 1)	I <sub>D</sub>	7.9	-6.7	A
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	30	-30	A
Total Power Dissipation @T <sub>A</sub> =25°C (Note 1)	P <sub>d</sub>	2.0		W
Linear Derating Factor		0.016		W / °C
Operating Junction and Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55~+150		°C
Thermal Resistance, Junction-to-Ambient (Note 1)	R <sub>th,j,a</sub>	62.5		°C/W

Note : 1.Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, 135°C/W when mounted on minimum copper pad  
 2.Pulse width limited by maximum junction temperature

**N-Channel Electrical Characteristics** (Tj=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	30	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =250µA
BV <sub>DSS</sub> /ΔT <sub>j</sub>	-	0.02	-	V/°C	Reference to 25 °C, I <sub>D</sub> =1mA
V <sub>GS(th)</sub>	1.0	1.5	3.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	1	µA	V <sub>DS</sub> =30V, V <sub>GS</sub> =0
	-	-	25	µA	V <sub>DS</sub> =24V, V <sub>GS</sub> =0, T <sub>j</sub> =70°C
*R <sub>DS(ON)</sub>	-	-	14	mΩ	I <sub>D</sub> =9A, V <sub>GS</sub> =10V
	-	-	20		I <sub>D</sub> =5A, V <sub>GS</sub> =4.5V
*G <sub>FS</sub>	-	14	-	S	V <sub>DS</sub> =10V, I <sub>D</sub> =9A
<b>Dynamic</b>					
C <sub>iss</sub>	-	1770	2830	pF	V <sub>DS</sub> =25V, V <sub>GS</sub> =0, f=1MHz
C <sub>oss</sub>	-	430	-		
C <sub>rss</sub>	-	350	-		
*t <sub>d(ON)</sub>	-	14	-	ns	V <sub>DS</sub> =15V, I <sub>D</sub> =1A, V <sub>GS</sub> =10V, R <sub>G</sub> =3.3 Ω, R <sub>D</sub> =15 Ω
*t <sub>r</sub>	-	10	-		
*t <sub>d(OFF)</sub>	-	36	-		
*t <sub>f</sub>	-	17	-		
*Q <sub>g</sub>	-	23	65	nC	V <sub>DS</sub> =24V, I <sub>D</sub> =9A, V <sub>GS</sub> =4.5V
*Q <sub>gs</sub>	-	6	-		
*Q <sub>gd</sub>	-	14	-		
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	-	1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =1.7A
*t <sub>rr</sub>	-	31	-	ns	I <sub>S</sub> =9A, V <sub>GS</sub> =0, dI/dt=100A/µs
*Q <sub>rr</sub>	-	25	-	nC	

\*Pulse Test : Pulse Width ≤300µs, Duty Cycle ≤2%



**P-Channel Electrical Characteristics** (T<sub>j</sub>=25°C, unless otherwise specified)

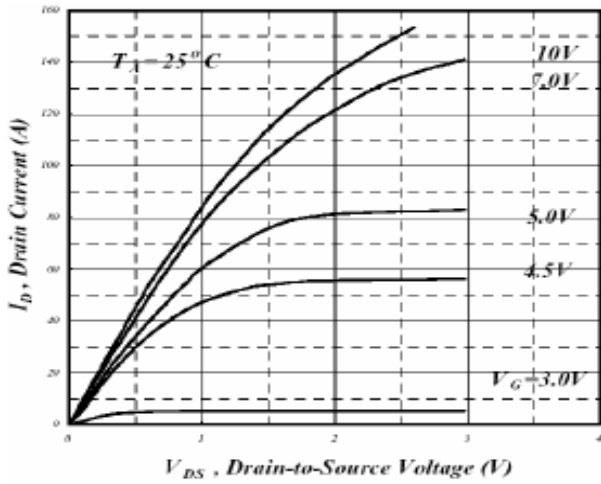
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	-30	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =-250μA
BV <sub>DSS</sub> /ΔT <sub>j</sub>	-	-0.02	-	V/°C	Reference to 25 °C, I <sub>D</sub> =-1mA
V <sub>GS(th)</sub>	-1.0	-	-3.0	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	-1	μA	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0
	-	-	-25	μA	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0, T <sub>j</sub> =70°C
*R <sub>DSON</sub>	-	-	20	mΩ	I <sub>D</sub> =-8A, V <sub>GS</sub> =-10V
	-	-	30		I <sub>D</sub> =-4A, V <sub>GS</sub> =-4.5V
*G <sub>FS</sub>	-	14	-	S	V <sub>DS</sub> =-10V, I <sub>D</sub> =-8A
<b>Dynamic</b>					
C <sub>iss</sub>	-	1580	2530	pF	V <sub>DS</sub> =-25V, V <sub>GS</sub> =0, f=1MHz
C <sub>oss</sub>	-	540	-		
C <sub>rss</sub>	-	450	-		
*t <sub>d(ON)</sub>	-	16	-	ns	V <sub>DS</sub> =-15V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-10V, R <sub>G</sub> =3.3 Ω, R <sub>D</sub> =15 Ω
*t <sub>r</sub>	-	11	-		
*t <sub>d(OFF)</sub>	-	40	-		
*t <sub>f</sub>	-	25	-		
*Q <sub>g</sub>	-	27	45	nC	V <sub>DS</sub> =-24V, I <sub>D</sub> =-8A, V <sub>GS</sub> =-4.5V
*Q <sub>gs</sub>	-	4	-		
*Q <sub>gd</sub>	-	18	-		
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	-	-1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-1.7A
*t <sub>rr</sub>	-	40	-	ns	I <sub>S</sub> =-8A, V <sub>GS</sub> =0, dI/dt=100A/μs
*Q <sub>rr</sub>	-	32	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

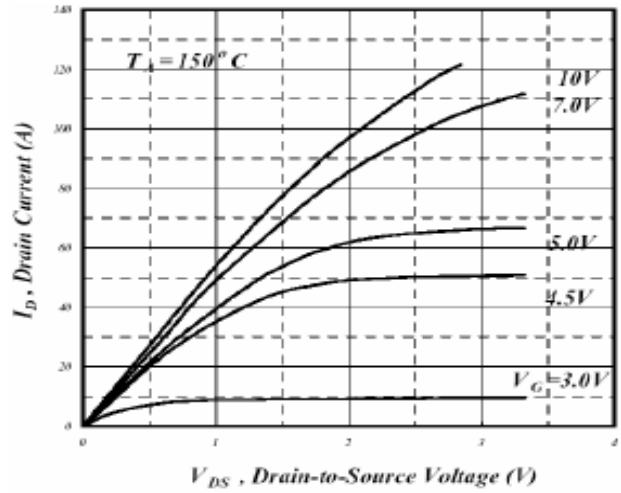
**Ordering Information**

Device	Package	Shipping	Marking
MTC4505Q8	SOP-8 (RoHS compliant)	3000 pcs / Tape & Reel	4505SS

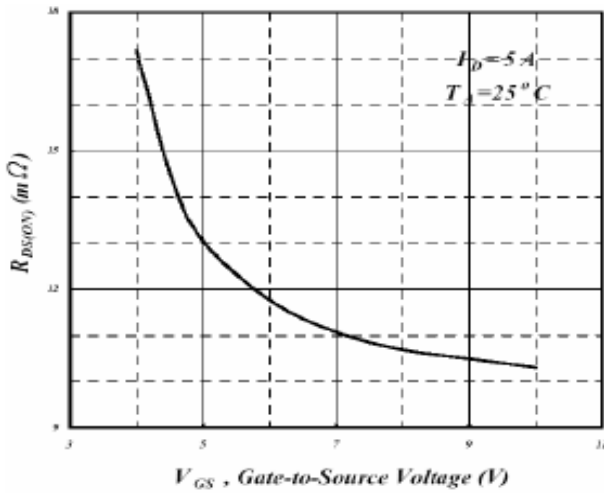
**N-channel Characteristic Curves**



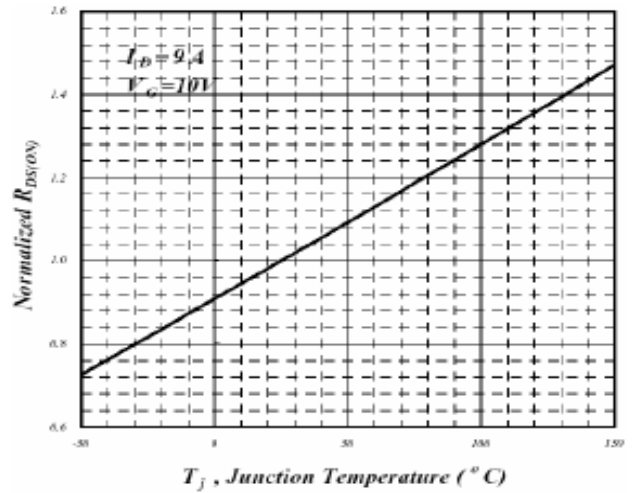
**Fig 1. Typical Output Characteristics**



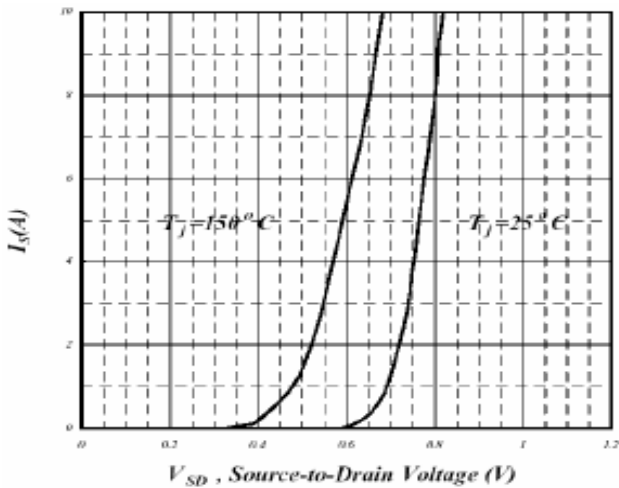
**Fig 2. Typical Output Characteristics**



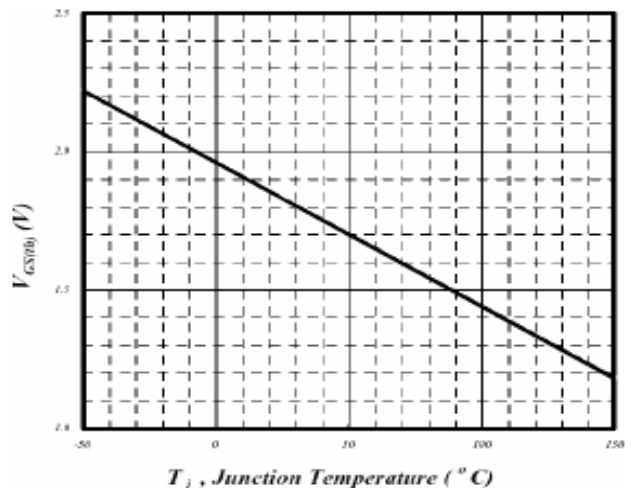
**Fig 3. On-Resistance vs. Gate Voltage**



**Fig 4. Normalized On-Resistance vs. Junction Temperature**

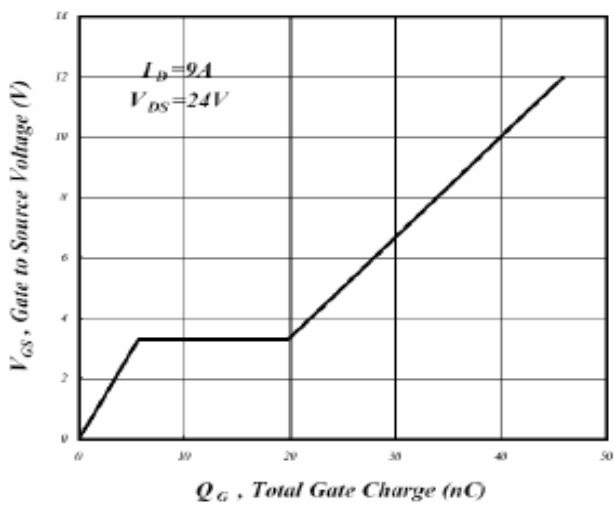


**Fig 5. Forward Characteristics of Reverse Diode**

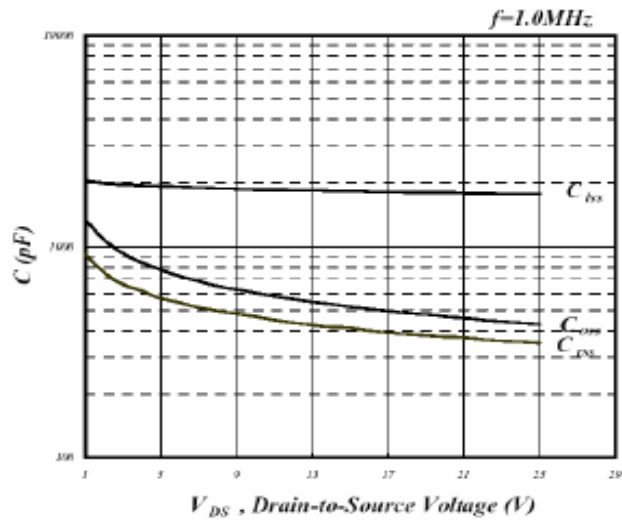


**Fig 6. Gate Threshold Voltage vs. Junction Temperature**

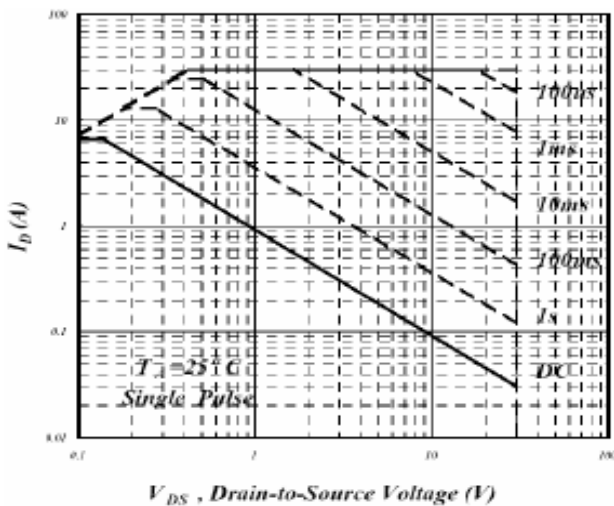
**N-channel Characteristic Curves(Cont.)**



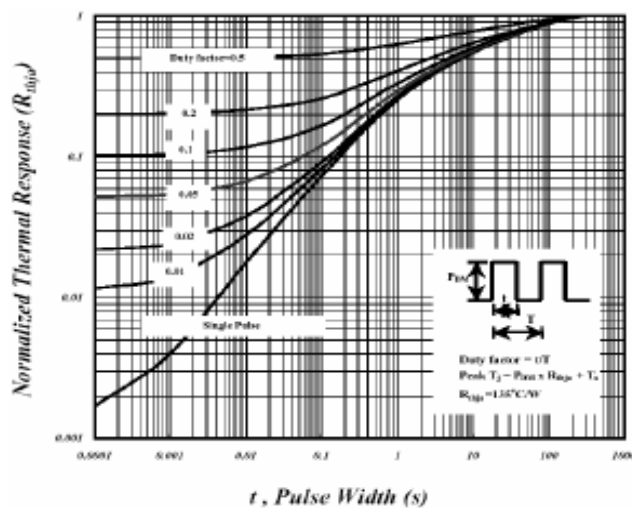
**Fig 7. Gate Charge Characteristics**



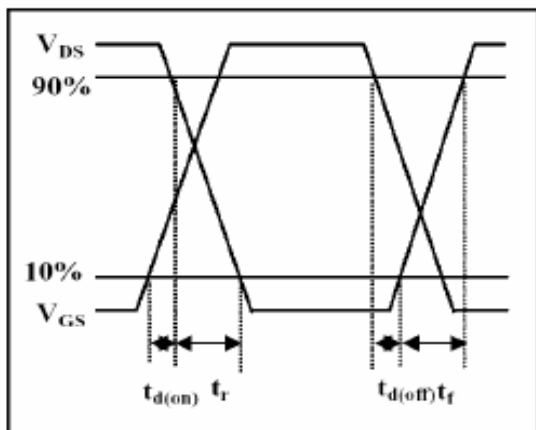
**Fig 8. Typical Capacitance Characteristics**



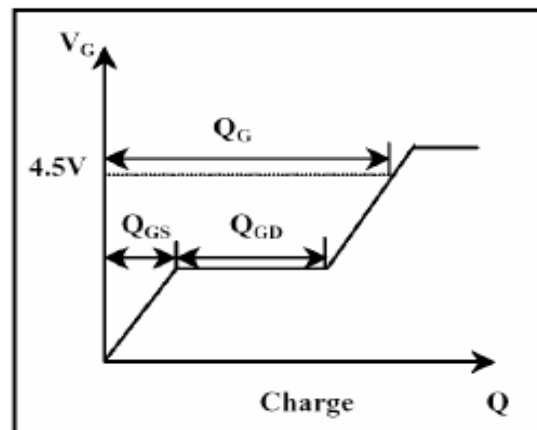
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**

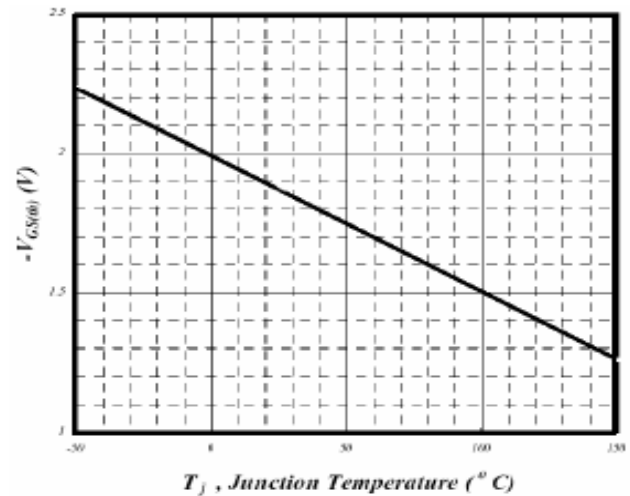
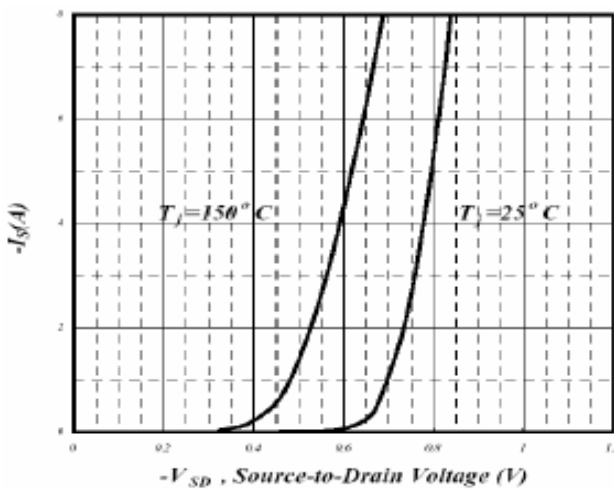
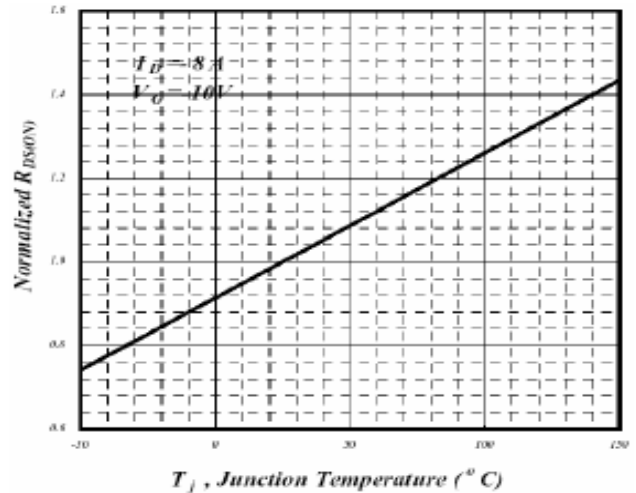
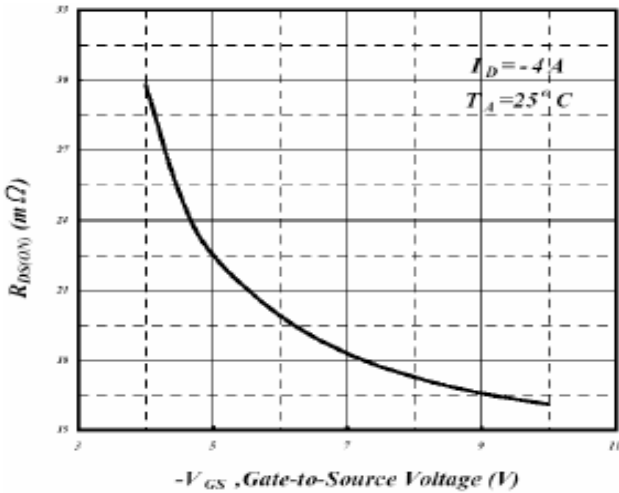
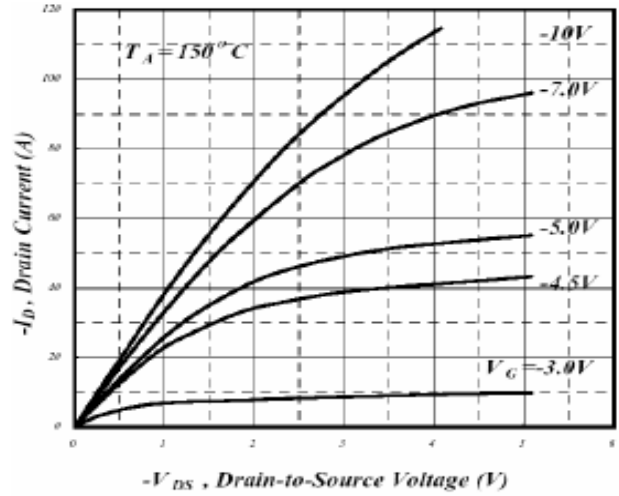
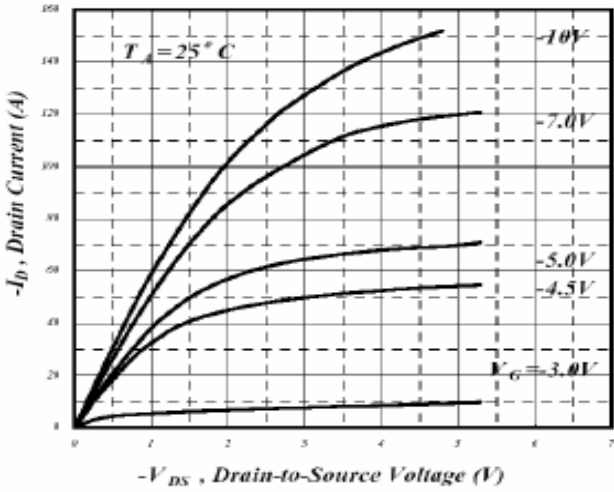


**Fig 11. Switching Time Waveform**

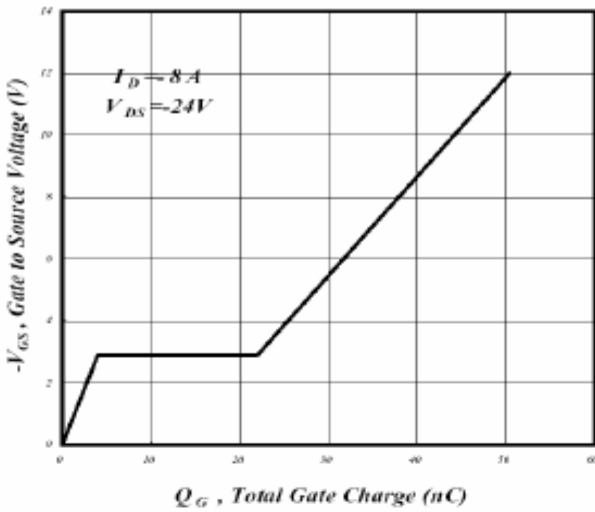


**Fig 12. Gate Charge Waveform**

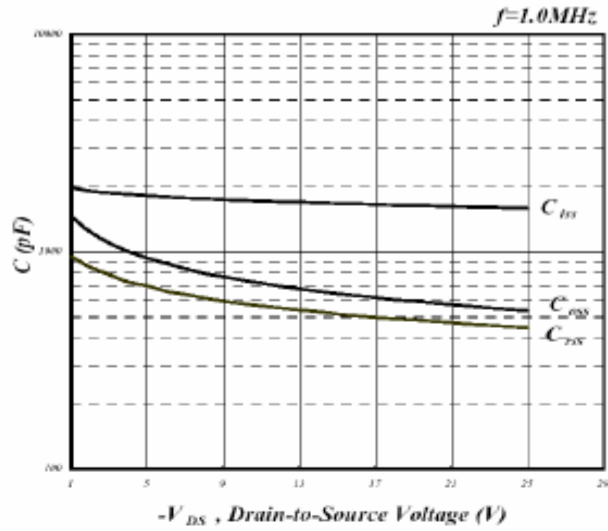
P-Channel Characteristic Curves



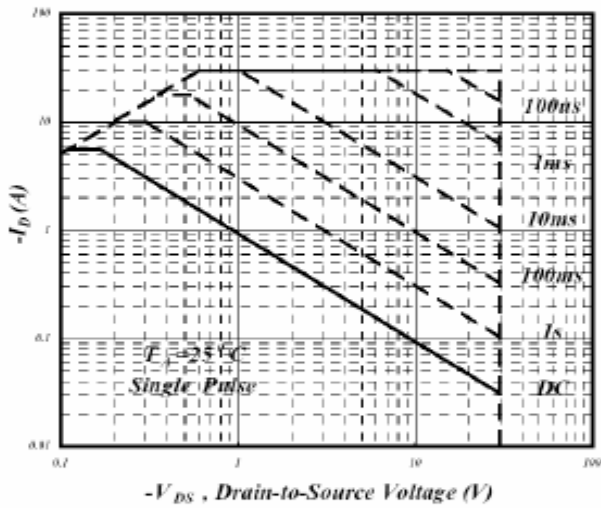
**P-channel Characteristic Curves(Cont.)**



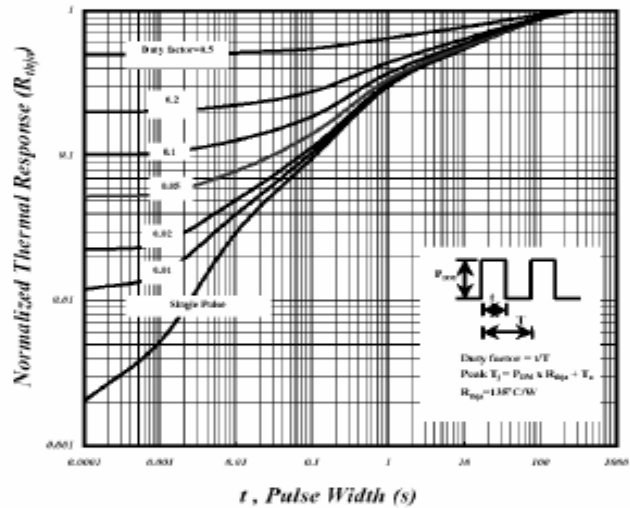
**Fig 7. Gate Charge Characteristics**



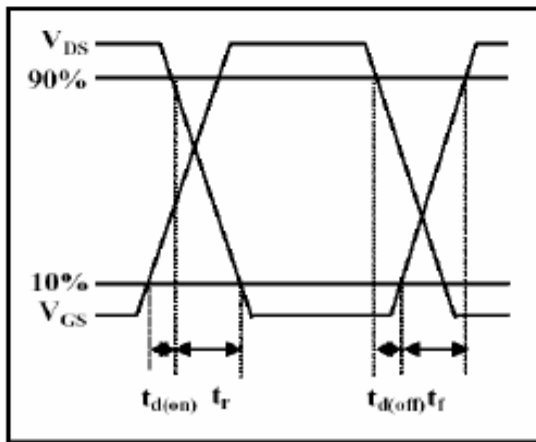
**Fig 8. Typical Capacitance Characteristics**



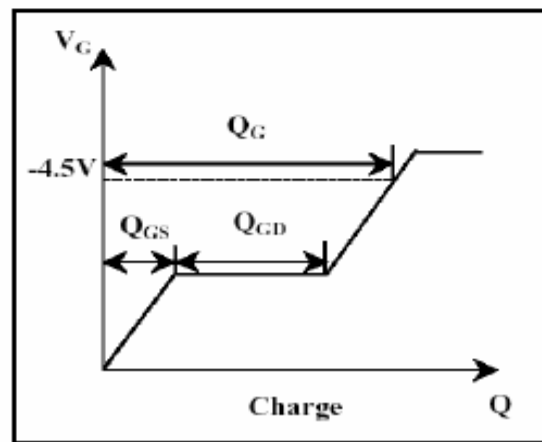
**Fig 9. Maximum Safe Operating Area**



**Fig 10. Effective Transient Thermal Impedance**

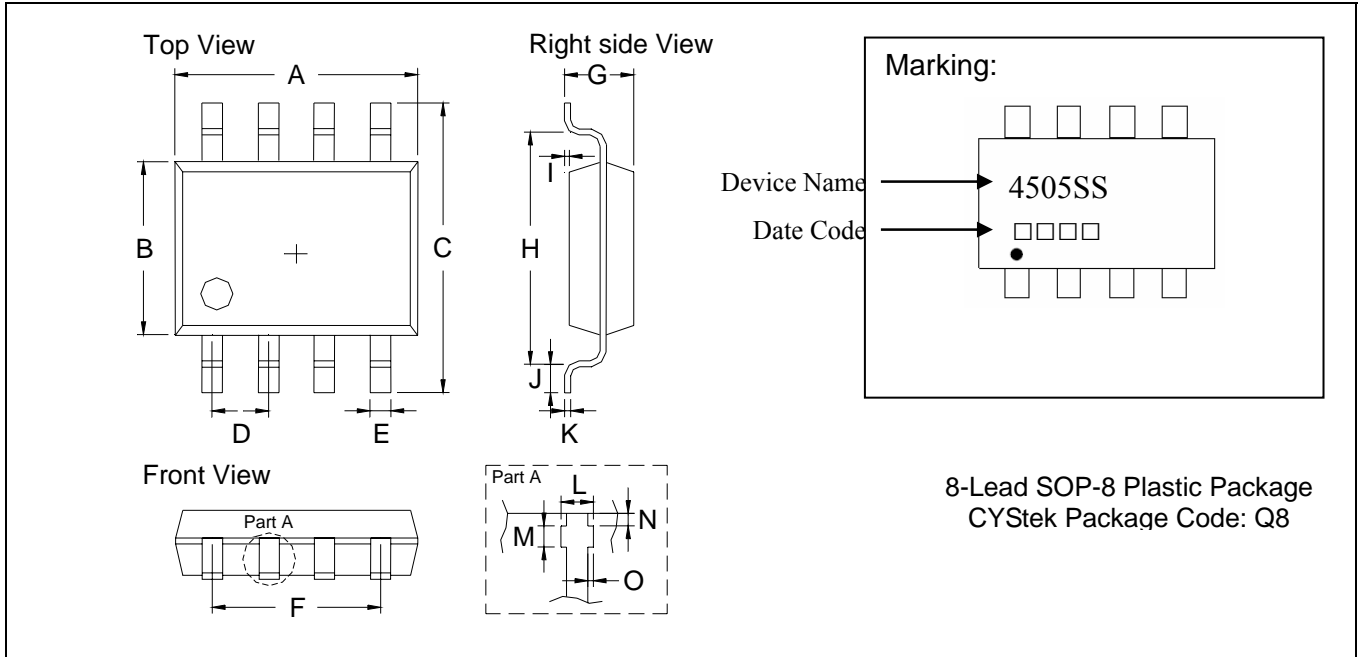


**Fig 11. Switching Time Waveform**



**Fig 12. Gate Charge Waveform**

**SOP-8 Dimension**



\*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1909	0.2007	4.85	5.10	I	0.0019	0.0078	0.05	0.20
B	0.1515	0.1555	3.85	3.95	J	0.0118	0.0275	0.30	0.70
C	0.2283	0.2441	5.80	6.20	K	0.0074	0.0098	0.19	0.25
D	0.0480	0.0519	1.22	1.32	L	0.0145	0.0204	0.37	0.52
E	0.0145	0.0185	0.37	0.47	M	0.0118	0.0197	0.30	0.50
F	0.1472	0.1527	3.74	3.88	N	0.0031	0.0051	0.08	0.13
G	0.0570	0.0649	1.45	1.65	O	0.0000	0.0059	0.00	0.15
H	0.1889	0.2007	4.80	5.10					

- Notes: 1. Controlling dimension: millimeters.  
 2. Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.  
 3. If there is any question with packing specification or packing method, please contact your local CYStek sales office.

**Material:**

- Lead: KFC ; pure tin plated plating
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0

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